

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Inventors: Junichi AIZAWA, et al.

Application No.: New PCT National Stage Application

Filed: February 20, 2002

For: DATA TRANSMITTING APPARATUS AND DATA
TRANSMITTING METHOD

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner of Patents
Washington, DC 20231

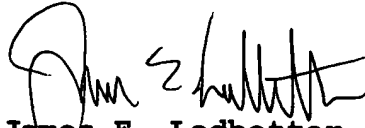
Sir:

Pursuant to Rules 56 and 99, Applicants hereby call the attention of the Patent Office to the references listed on the attached Form PTO 1449. All of these references were cited in a PCT International Search Report (copy attached) except for JP '196.

Applicants present this art so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rules 104 and 106.

Applicants respectfully request that this art be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom.

Respectfully submitted,



James E. Ledbetter
Registration No. 28,732

Date: February 20, 2002

JEL/spp

ATTORNEY DOCKET NO. L9289.02122

STEVENS, DAVIS, MILLER & MOSHER, L.L.P.
1615 L Street, NW, Suite 850
P.O. Box 34387
Washington, DC 20043-4387
Telephone: (202) 785-0100
Facsimile: (202) 408-5200

U.S. Department of Commerce
Patent and Trademark Office

Unassigned

[illegible]

		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
														YES	NO
		0	5	1	6	0	7	7	7	06/1993	JP			Abstract	
		0	9	3	1	2	6	2	9	12/1997	JP			Abstract	
		1	1	0	1	7	6	4	6	01/1999	JP			Abstract	
		2000		0	0	4	1	9	6	01/2000	JP			Abstract	

T. NIINOMI, et al.; "Selective Repeat Type-II Hybrid ARQ/FEC Scheme Using Rate-Compatible Punctured Convolutional Code", Communications, (1990), ICC '90, Including Supercomm Technical Sessions, SUPERCOMM/ICC '90, Conference Record, IEEE International Conference on, (1990), Vol. 3, pp. 1251-1255.

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.